

OT406

Four-quadrant triac, enhanced noise immunity

Rev. 01 — 19 May 2008

Product data sheet

1. Product profile

1.1 General description

Passivated sensitive gate triac in a SOT223 surface-mountable plastic package

1.2 Features

- Sensitive gate
- Direct interfacing to logic level ICs
- Enhanced immunity to voltage transients and noise
- Gate triggering in four quadrants
- Direct interfacing to low power gate drive circuits
- Blocking voltage to 600 V

1.3 Applications

- Home appliances
- Low power AC fan speed controllers
- Low power motor control
- Low power loads in industrial process control

1.4 Quick reference data

- $V_{DRM} \leq 600$ V
- $I_{TSM} \leq 12.5$ A ($t = 20$ ms)
- $I_{T(RMS)} \leq 1$ A
- $I_{GT} \leq 3$ mA
- $I_{GT} \leq 5$ mA (T2– G+)

2. Pinning information

Table 1. Pinning

| Pin | Description | Simplified outline | Graphic symbol |
|-----|-------------------------------------|--------------------|----------------|
| 1 | main terminal 1 (T1) | <p>SOT223</p> | <p>sym051</p> |
| 2 | main terminal 2 (T2) | | |
| 3 | gate (G) | | |
| 4 | mounting base; main terminal 2 (T2) | | |

3. Ordering information

Table 2. Ordering information

| Type number | Package | | Version |
|-------------|---------|--|---------|
| | Name | Description | |
| OT406 | SC-73 | plastic surface-mounted package with increased heatsink; 4 leads | SOT223 |

4. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|--------------|--------------------------------------|---|-----|------|-------------|
| V_{DRM} | repetitive peak off-state voltage | | - | 600 | V |
| V_{RRM} | repetitive peak reverse voltage | | - | 600 | V |
| $I_{T(RMS)}$ | RMS on-state current | full sine wave; $T_{sp} \leq 103\text{ °C}$; see Figure 4 and 5 | - | 1 | A |
| I_{TSM} | non-repetitive peak on-state current | full sine wave; $T_j = 25\text{ °C}$ prior to surge; see Figure 2 and 3 | | | |
| | | $t = 20\text{ ms}$ | - | 12.5 | A |
| | | $t = 16.7\text{ ms}$ | - | 13.8 | A |
| I^2t | I^2t for fusing | $t_p = 10\text{ ms}$ | - | 1.28 | A^2s |
| di_T/dt | rate of rise of on-state current | $I_{TM} = 1\text{ A}$; $I_G = 20\text{ mA}$; $di_G/dt = 0.2\text{ A}/\mu s$ | | | |
| | | T2+ G+ | - | 50 | $A/\mu s$ |
| | | T2+ G- | - | 50 | $A/\mu s$ |
| | | T2- G- | - | 50 | $A/\mu s$ |
| | | T2- G+ | - | 10 | $A/\mu s$ |
| I_{GM} | peak gate current | | - | 1 | A |
| P_{GM} | peak gate power | | - | 2 | W |
| $P_{G(AV)}$ | average gate power | over any 20 ms period | - | 0.1 | W |
| T_{stg} | storage temperature | | -40 | +150 | $^{\circ}C$ |
| T_j | junction temperature | | - | 125 | $^{\circ}C$ |

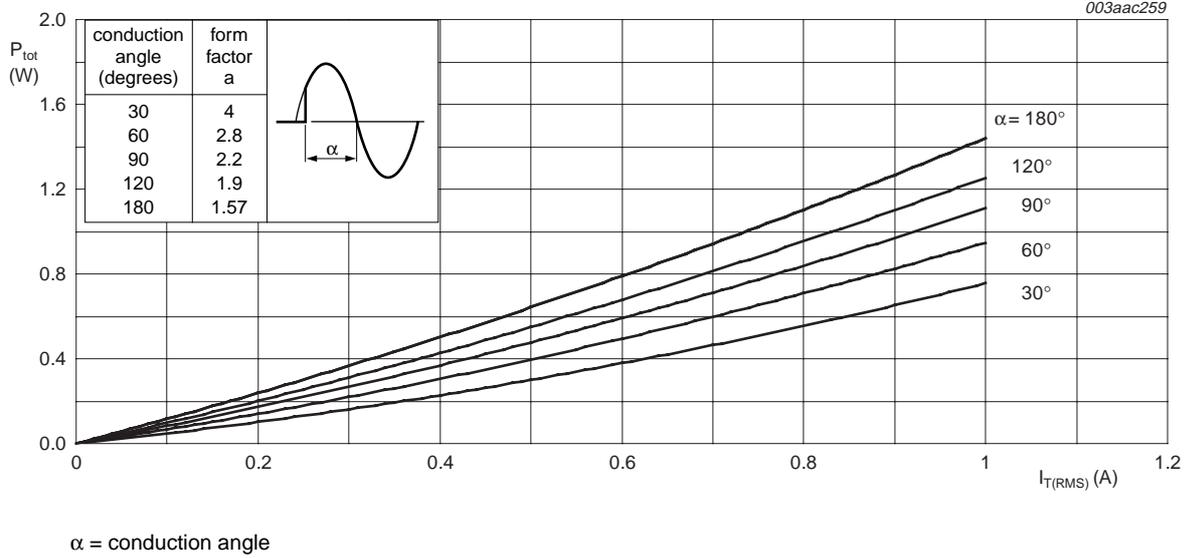


Fig. 1. Total power dissipation as a function of RMS on-state current; maximum values

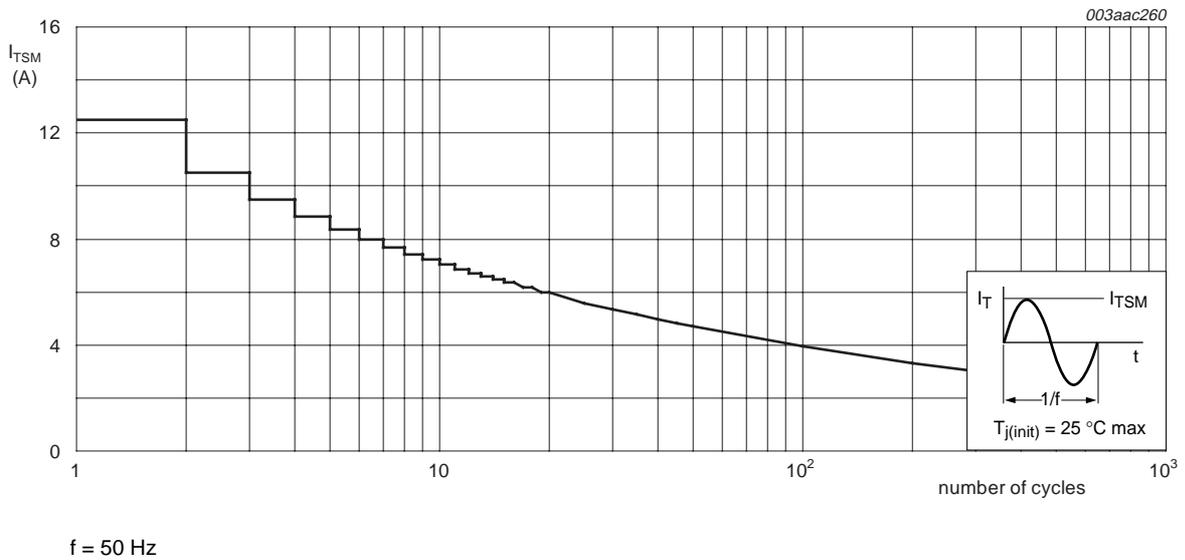


Fig. 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

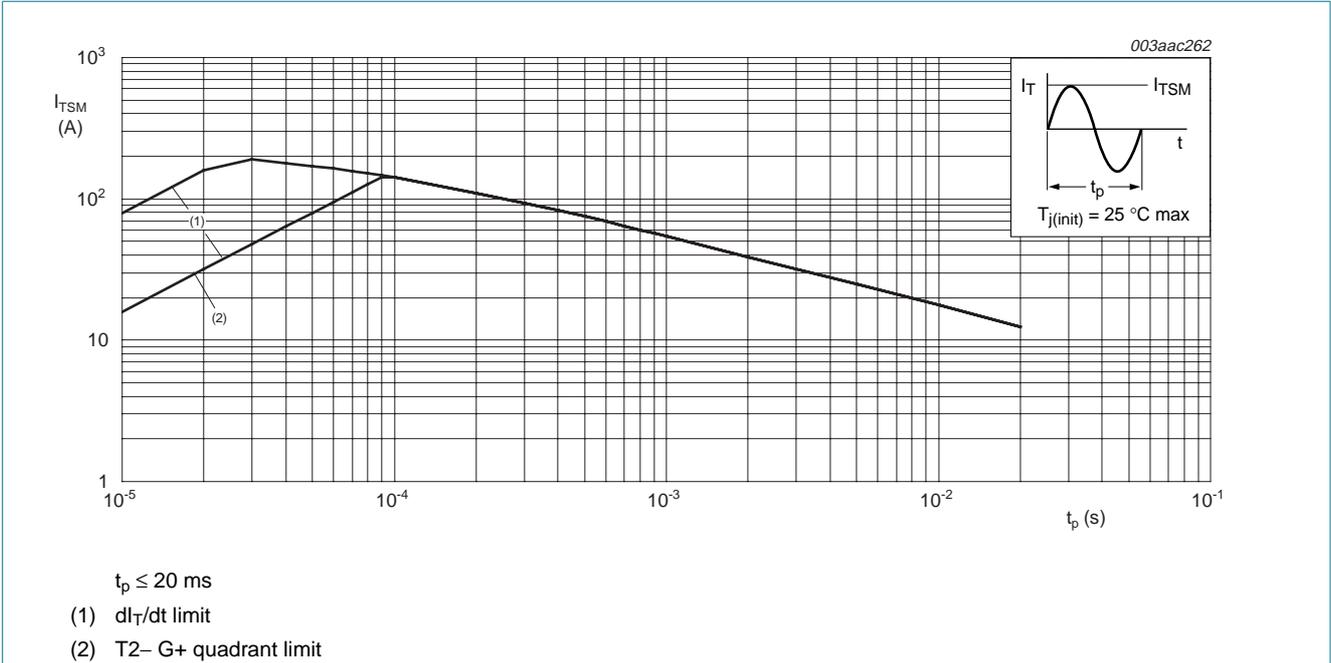


Fig 3. Non-repetitive peak on-state current as a function of pulse width; maximum values

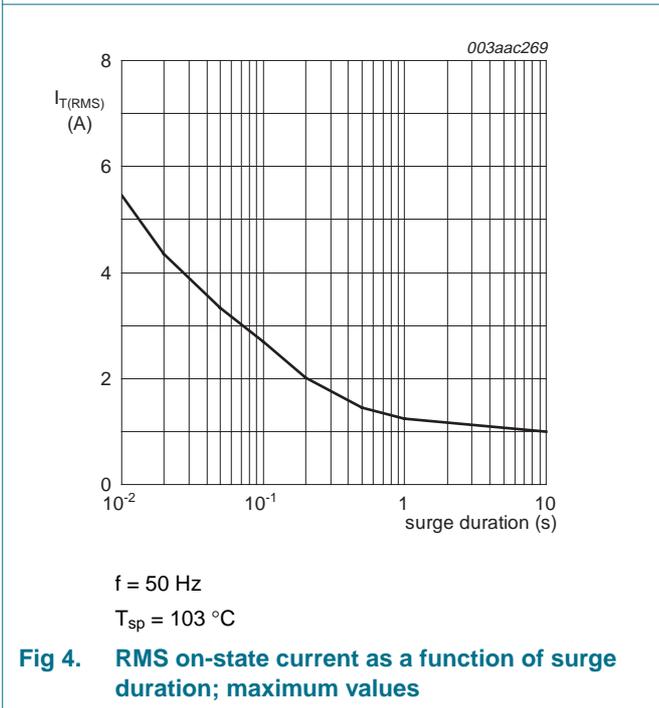


Fig 4. RMS on-state current as a function of surge duration; maximum values

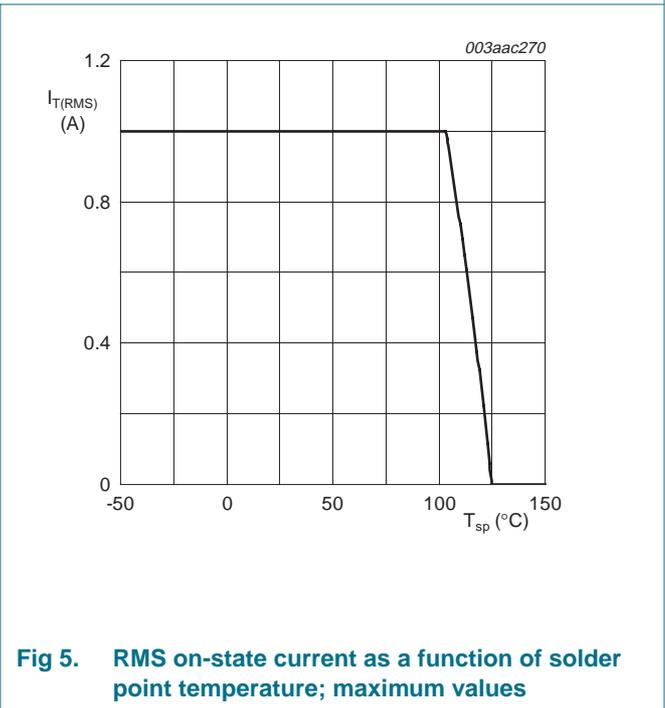


Fig 5. RMS on-state current as a function of solder point temperature; maximum values

5. Thermal characteristics

Table 4. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|----------------|--|---|-----|-----|-----|------|
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point | full cycle; see Figure 6 | - | - | 15 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | full cycle | | | | |
| | | for minimum footprint see Figure 13 | - | 156 | - | K/W |
| | | for pad area see Figure 14 | - | 70 | - | K/W |

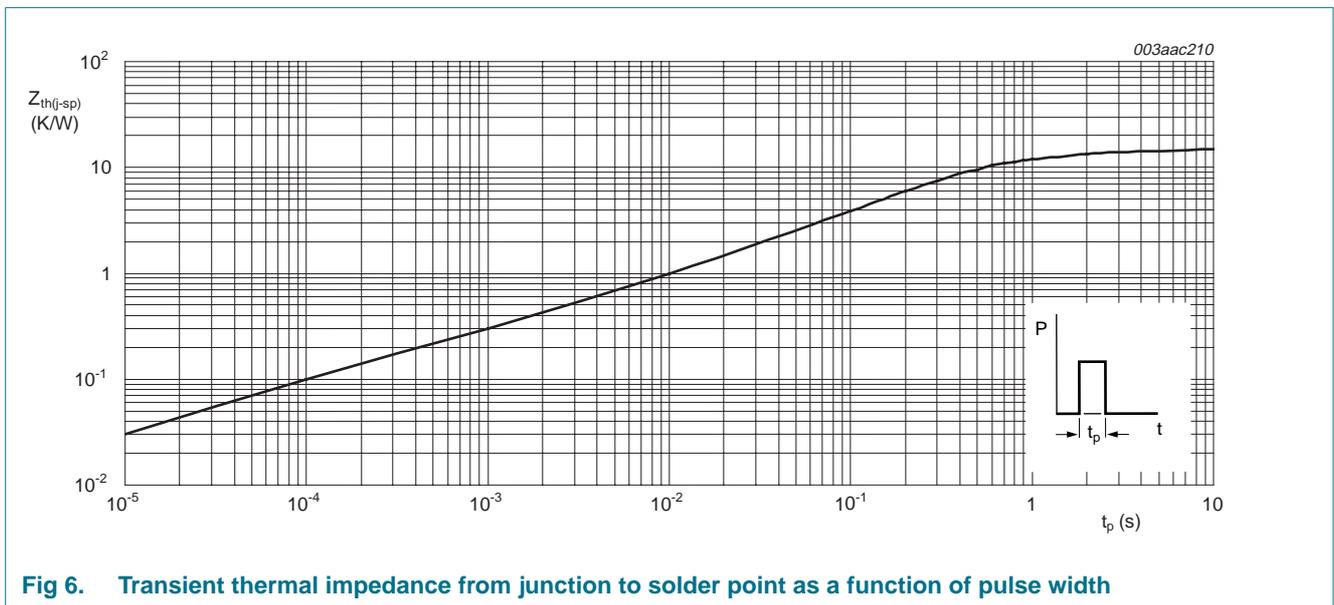


Fig 6. Transient thermal impedance from junction to solder point as a function of pulse width

6. Static characteristics

Table 5. Static characteristics

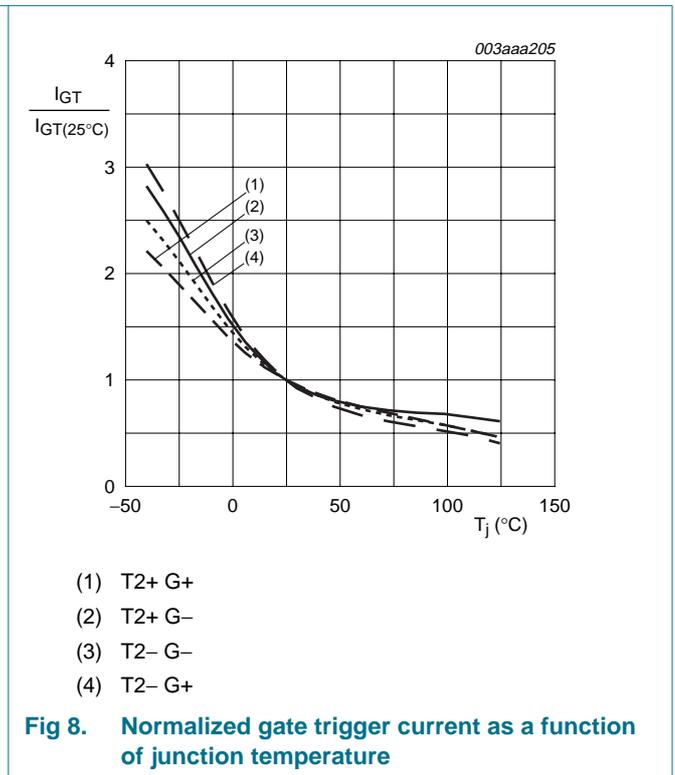
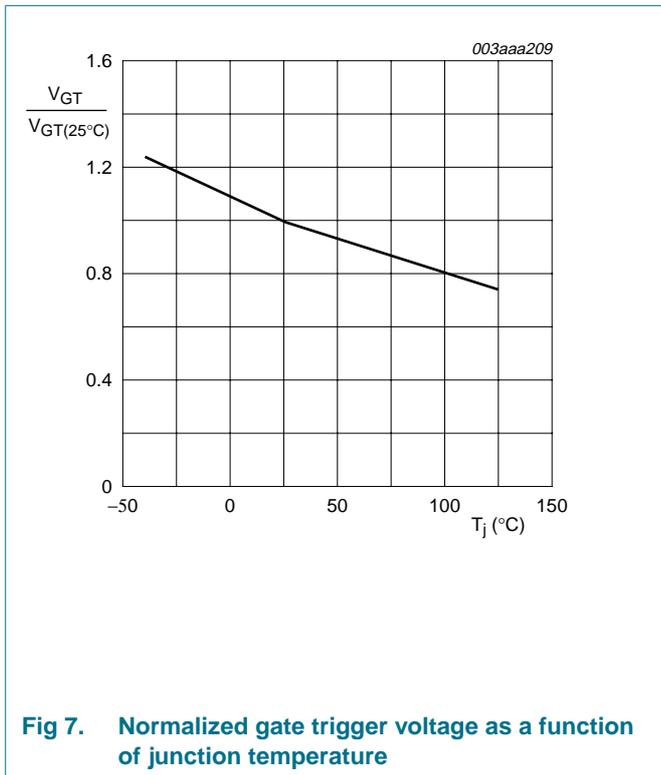
$T_j = 25\text{ °C}$ unless otherwise specified.

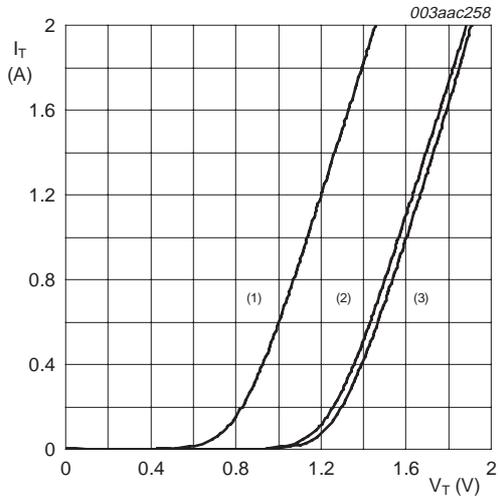
| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|----------|----------------------|--|-----|-----|-----|------|
| I_{GT} | gate trigger current | $V_D = 12\text{ V}$; $I_T = 0.1\text{ A}$; see Figure 8 | | | | |
| | | T2+ G+ | - | - | 3 | mA |
| | | T2+ G- | - | - | 3 | mA |
| | | T2- G- | - | - | 3 | mA |
| | | T2- G+ | - | - | 5 | mA |
| I_L | latching current | $V_D = 12\text{ V}$; $I_G = 0.1\text{ A}$; see Figure 10 | | | | |
| | | T2+ G+ | - | - | 7 | mA |
| | | T2+ G- | - | - | 20 | mA |
| | | T2- G- | - | - | 7 | mA |
| | | T2- G+ | - | - | 7 | mA |
| I_H | holding current | $V_D = 12\text{ V}$; $I_G = 0.1\text{ A}$; see Figure 11 | - | - | 7 | mA |
| V_T | on-state voltage | $I_T = 1\text{ A}$; see Figure 9 | - | 1.3 | 1.6 | V |
| V_{GT} | gate trigger voltage | $V_D = 12\text{ V}$; $I_T = 0.1\text{ A}$; see Figure 7 | - | - | 1.3 | V |
| | | $V_D = V_{DRM}$; $I_T = 0.1\text{ A}$; $T_j = 125\text{ °C}$ | 0.2 | - | - | V |
| I_D | off-state current | $V_D = V_{DRM(max)}$; $T_j = 125\text{ °C}$ | - | - | 0.5 | mA |

7. Dynamic characteristics

Table 6. Dynamic characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---------------|---------------------------------------|--|-----|-----|-----|------------------|
| dV_D/dt | rate of rise of off-state voltage | $V_{DM} = 0.67V_{DRM(max)}$; $T_j = 110\text{ }^\circ\text{C}$; exponential waveform; gate open circuit | 10 | - | - | V/ μs |
| dV_{com}/dt | rate of change of commutating voltage | $V_{DM} = 400\text{ V}$; $T_j = 110\text{ }^\circ\text{C}$; $I_{TM} = 1\text{ A}$; $di_{com}/dt = 0.44\text{ A/ms}$ | 0.5 | - | - | V/ μs |





- $V_o = 1.254 \text{ V}; R_s = 0.31 \ \Omega$
- (1) $T_j = 125 \text{ }^\circ\text{C}$; typical values
 - (2) $T_j = 125 \text{ }^\circ\text{C}$; maximum values
 - (3) $T_j = 25 \text{ }^\circ\text{C}$; maximum values

Fig 9. On-state current as a function of on-state voltage

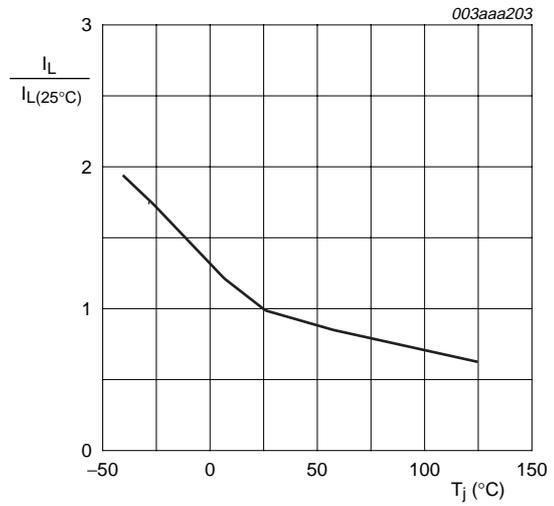


Fig 10. Normalized latching current as a function of junction temperature

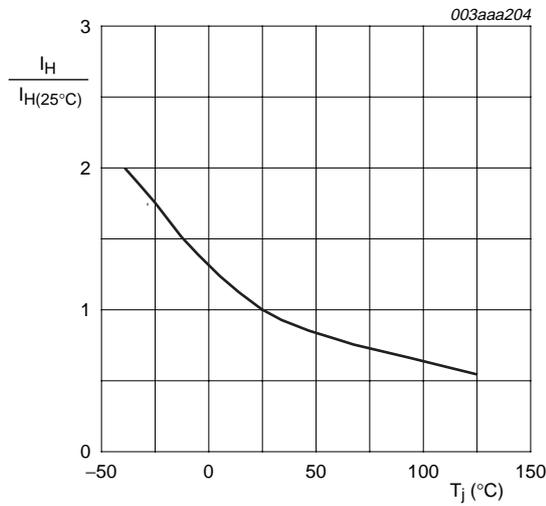


Fig 11. Normalized holding current as a function of junction temperature

8. Package outline

Plastic surface-mounted package with increased heatsink; 4 leads

SOT223

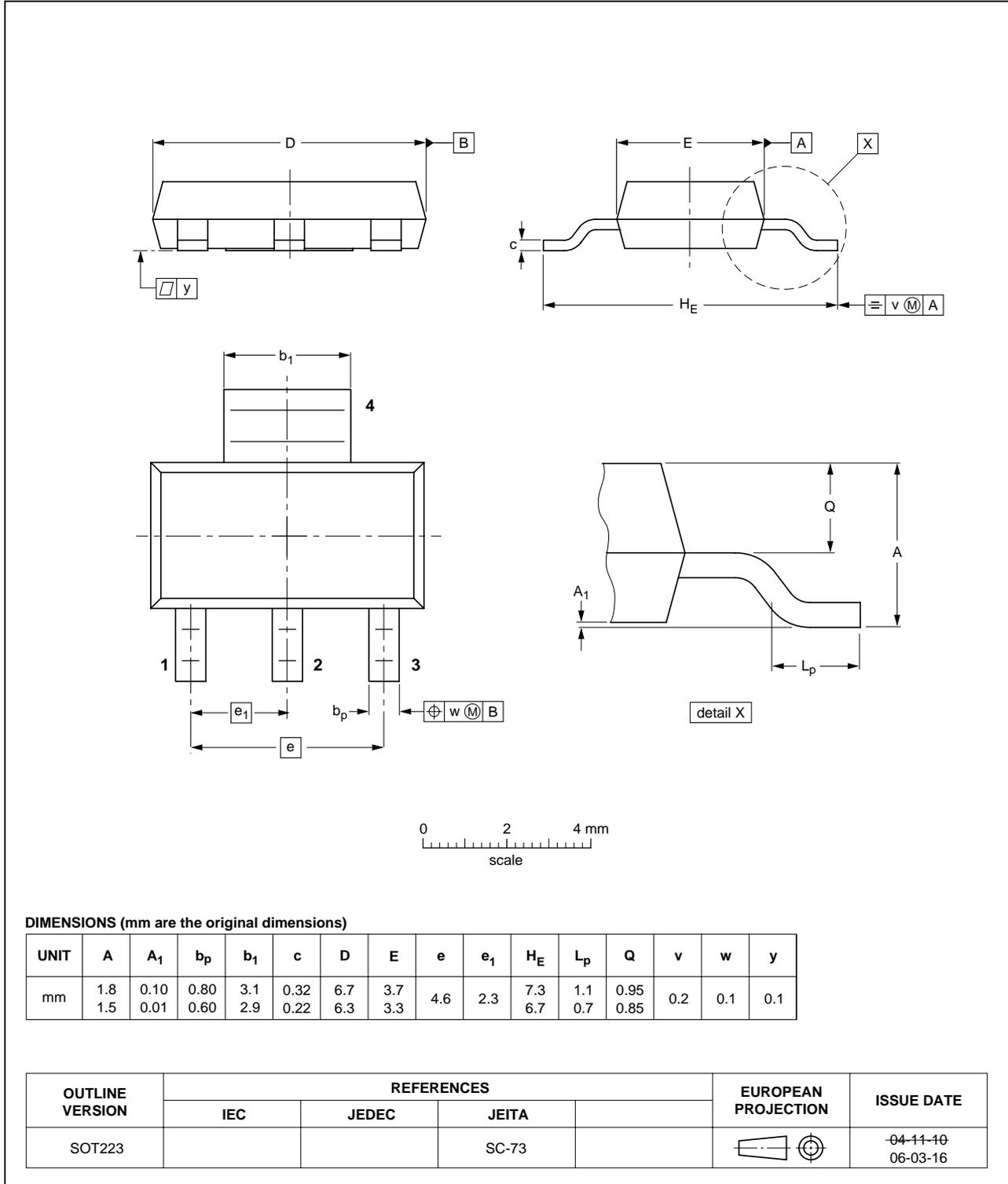
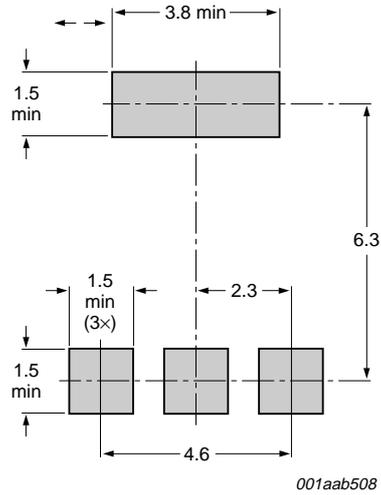


Fig 12. Package outline SOT223 (SC-73)

9. Mounting

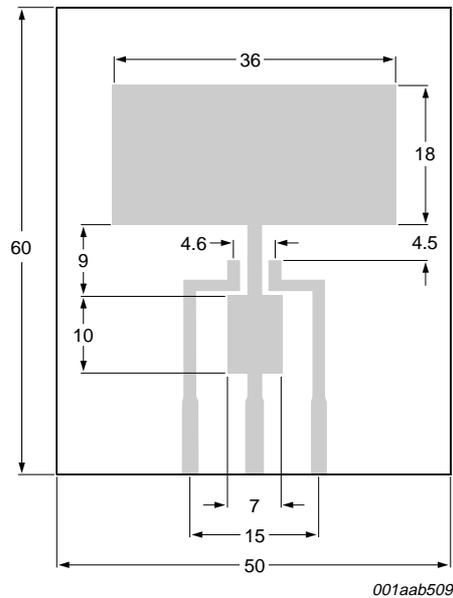
9.1 Mounting instructions



All dimensions are in mm

Fig 13. Minimum footprint SOT223

9.2 Printed-circuit board



All dimensions are in mm

Printed-circuit board: FR4 epoxy glass (1.6 mm thick), copper laminate (35 μm thick)

Fig 14. Printed-circuit board pad area SOT223

10. Revision history

Table 7. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|-------------|--------------|--------------------|---------------|------------|
| OT406_1 | 20080519 | Product data sheet | - | - |

11. Legal information

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| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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